Search Notes



| Application/Control | No. | |
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09/894,827 Examiner

John S. Chu

Applicant(s)/Patent under Reexamination

FUKUSHIGE ET AL.

Art Unit

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| Class | Subclass | Date | Examiner |
| 430 | 138 | 2/2007 | jse |
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| SEARCH NOTES (INCLUDING SEARCH STRATEGY) | | | |
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